Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/603,062	KIM ET AL.	
Examiner	**Art Unit**	
Thien D. Tran	2616	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT)	7/6/2006	TT